

<b>Notice of References Cited</b>	Application/Control No. 10/734,440		Applicant(s)/Patent Under Reexamination SAMPATH ET AL.	
	Examiner SHICK C. HOM		Art Unit 2416	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0027840 A1	02-2005	Theobold et al.	709/223
*	B	US-2003/0065712 A1	04-2003	Cheung et al.	709/203
*	C	US-6,801,501 B1	10-2004	Knightly et al.	370/233
*	D	US-5,483,676 A	01-1996	Mahany et al.	455/67.14
*	E	US-7,075,913 B1	07-2006	Yavuz et al.	370/335
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.